Search Notes



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Applicant(s)/Patent Under Reexamination

LOW, YEE CHEOK

Examiner

HENOK G HEYI

Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
Searched EAST. Some of the subclasses searched are 369/30.36, 44.27	02/20/2009	HH
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INTERFERENCE SEARCH

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